

REPLACEMENT SHEET

Title: Optical Probe for Wafer Testing

1st Named Inventor: Kjetil Johannessen

Application No.: 10/040,398

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Sheet: 1/1

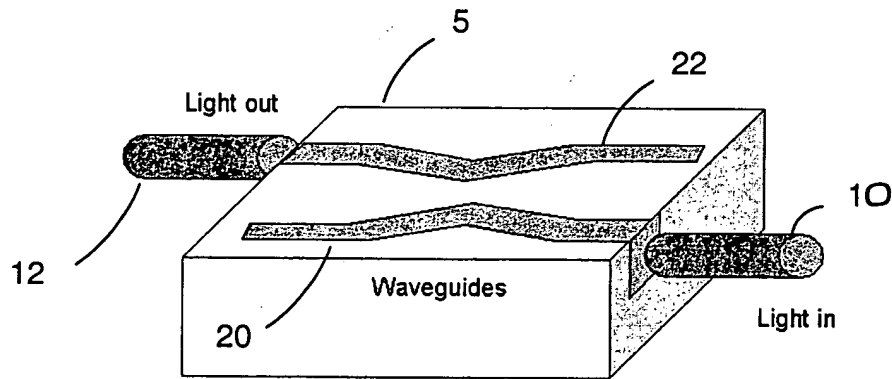


FIG. 1

PRIOR ART